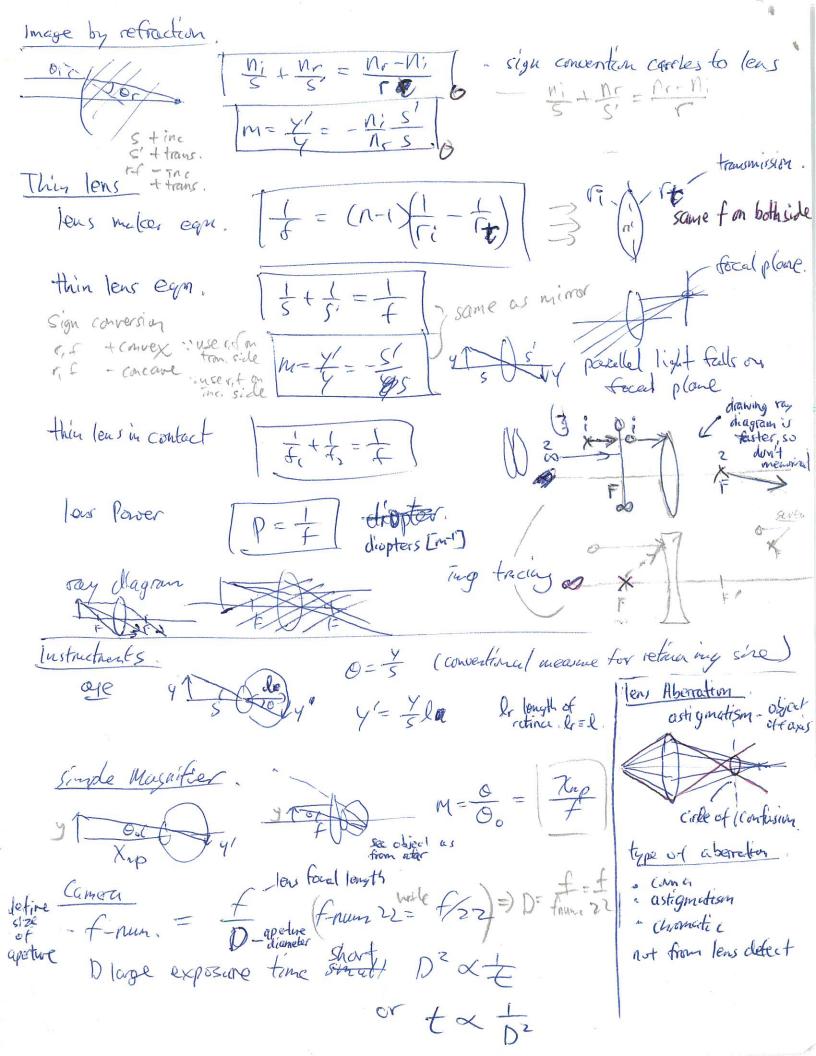
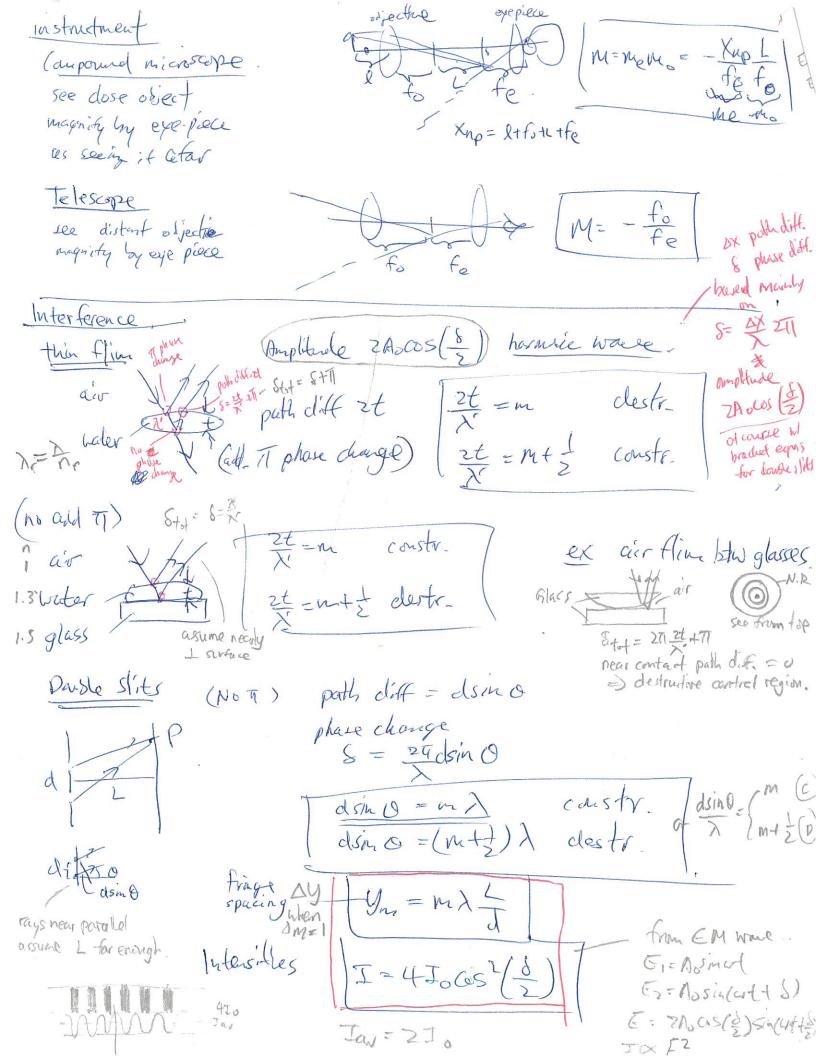
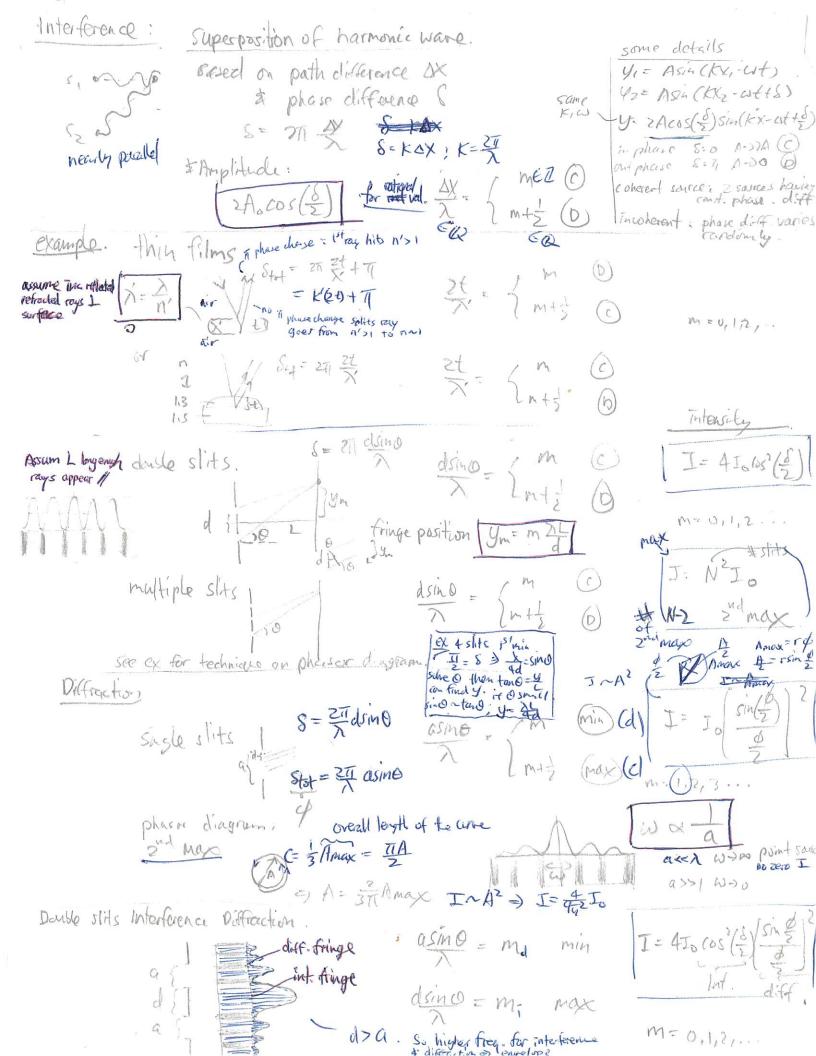
Optics * reflection |Oi=Or| intensity $I_r = \frac{(n_i - N_r)^2}{(n_i + n_r)^2} I_o$ Shell's Law * refraction SinOr no Intensity Io = IF + Ir plane wave e ickx wit) RE IN TE ITO n= & Cotos v the total internal reflection $\theta_r = 90^\circ$ (n; >nr) $\sin \theta_c = \frac{n_r}{n_r}$ EN K SLEW I=R+T rreathe violet of so A fixed Ard sinds ord & Polarration. Sylvel (analogue) Alsonption (Polarizer) Quantum (Scattering) The transmission exis Ar A sind A Ort blue of red 788nm Malus's law I= Ivas20 step pototical, refor To reflected light
Timedy played. Eventur
Plane of rester

plane of surface Brewsters law: At Op reflected ray polarized and Optor = 90" tan Op = Mr | Brewster's angle of polarized · Polatad incident very has no reflected very at Op The polarized lille Spherical miner 7+ 3 = + f= 5 Swiface incidence · ray diagram (Entral $M = \frac{y}{5} = -\frac{5}{5}$ 6 Sign convention 0 > 0 < 0 1't + concesse ing tracing image tracing (concave mirror) behind Fing red invoted · Samp focus point S behind C Try between CF Small paraxial: · parallel rays are paraxial · valid for small 0 Shetween CF ing behind Clarge Sat F y/200 Statusen FV, mg exected large virtual (Convex) ing erected & virtual between VF Nonparaxial ray - blurry image with remonder spherial aboration Y'at V, Ymax = y same intual excited





multiple Slits dsino=vik new wax = Ausina Intersity z Ausin(U+S) = AsiH(d+25) S= a S=0 Amplitude 3A0=> I= 9I. $I = I_{s}\left(\frac{\sin\left(\frac{\delta}{2}\right)}{\frac{\delta}{2}}\right)$ Withraction diagram. Tasmo = ma wed hier -NAs arcleists phasor A= 3 Amax S= 21 dsino Ez = Assis(x+8. Stol = 27 asino E= F,+ F, =2\$ cos(\frac{\xi}{2}) sin(\d+ & Double Slits Interference Vistraction. $T = 4T_0 \cos^2\left(\frac{\delta}{2}\right) \left(\frac{\sin\frac{\phi}{2}}{2}\right)^2.$ diffraction frag asin 0 = mi l dino=ml difference May diffrex pettern. I Frauchofer: I'mene 1 Freshe closer t D'Hacker & Resolution Rayleight's criterion for resolution s centr. Max icroscope & 10 dc = 1.22 d for telescope DM spectrosche N# of slike



lassification of Diffraction o traumhofer pottern assumptions. (1) plane wave incident normally on slit (2) L>> a note a>> > (ie 1000 >) no fraunhofer pattern. b/k very small minimum (chy!) ble (asing m) and w smalls rays appears partlet always. Fresnel pattern as Lnear a, fresnel pattern. App. of Fraunhofer diffraction "Resolution" when 1st min of s, falls on central nax of Sz. we have first diffraction minimum large angles to seperate light Sie 00 substended by angle DSMOC= 1.22 Ochall Sz Daperture diameter Source define. Oc= 1.22 D Rayleigh's cliterion. (00) mage not overlap. Fer clear resolution, DA for reieroscope want of small (6) unresidued resolution Michelso Interferometer (act like air film) App · redefine standard meter (measured Krypton & 6 emitted (-ght) Mi. like airfilm · measure Pair X= 1. (air) · measure light speed difference. Diffraction Gratings interference due to reflection on ridges. dillo maxima; dsino = m - order number · more source shaper maxima. da 10tcm OBragg's Diffaction · resolution power of spectroscope for nearly his x-ray 2 = 5 d x 2 d s (no = m max) 2 d s (no = m max) 3, ... OR = 1AX = MN - # Slits assume xindery m-1,2,3, ... app. Hologram. crystal lattice layer

